

Date Searched: 6/12/2006
Databases Searched: USPAT, USPGPUB
Plurals: ON

Terms Searched:

- L1 (transistor or transistor) same (current near3 (source or driver))
- L2 (current near3 (source or driver)) near15 (width or dimension or size)
- L3 resist\$5
- L4 (model\$3 or character\$8 or represent\$6) same 2
- L5 2 and 3 and 4

Results: 1167 hits

- L6 (716/1-18.ccls. or 703/2.ccls.) and 5
- Results: 19 hits

- L7 (transistor or transistor) same (replac\$6 or substitut\$4 or represent\$6 or model\$3 or character\$8) same current

- L8 current same (width or size or dimension)

- L9 7 and 8

- L10 (716/1-18.ccls. or 703/2.ccls.) and 9

Results: 305 hits

- L11 current same (distribut\$4 or aggregat\$4 or combin\$7 or total) same 8

- L12 10 and 11

Results: 96 hits

- L13 3 and 12

Results: 74 hits

- L14 memory near2 array

- L15 row same 14

- L16 716/1-18.ccls. and 15

- L17 (emf or em or migration or electro-migration or electromigration)

- L18 16 and 17

Results: 10 hits

Fujine; Eiji US 6748572 B2
Sutherland; Ivan et al. US 6629301 B1
Yonezawa; Hirokazu et al. US 6219630 B1
Fujine, Eiji US 20020199160 A1
Mau, Hendrik T. et al. US 20040168136 A1
SHINOMIYA, NORIKO et al. US 20010049815 A1
Somayaji; Ananth G et al. US 7043705 B2
Narahara; Hidetoshi et al. US 7039572 B1
Kartschoke, Paul D. et al. US 20050278662 A1
Heydler, Thomas et al. US 20040015787 A1
Itazu; Kazushige et al. US 6405354 B1
Young; Duane J. et al. US 6038383 A
Yonezawa, Hirokazu US 20040261044 A1
Chatterjee, Amitava et al. US 20020083399 A1
Van Heijningen; Marc et al. US 6941258 B2
Mau; Hendrik T. et al. US 6880139 B2
AKINO, T et al. JP 09102608 A
Hassibi; Arash et al. US 6954921 B2
Colleran; David M. et al. US 6909330 B2
Yamaguchi; Kenji US 6735558 B1
Demler; Michael J. US 6637018 B1
King; Ken Richard et al. US 6286127 B1
Singh, Raminderpal et al. US 20050216873 A1
Yamaguchi, Kenji US 20040098681 A1
McGaughy; Bruce W. et al. US 6928626 B1

Rahmat; Khalid et al. US 20060031795 A1
Colleran, David M. et al. US 20040230408 A1
Hassibi, Arash et al. US 20040172609 A1
Mitsuhashi; Takashi US 5404310 A
Yamaguchi; Tetsuya US 6757873 B2
Pie; Charles Corey et al. US 6631506 B1
Chatterjee; Amitava et al. US 6598214 B2
Chandra; Rajit et al. US 6591402 B1
Misheloff; Michael N. et al. US 5461579 A
Sugasawara; Emery O. et al. US 6102962 A
Tamaki; Yoichi et al. US 6662344 B2
Yasuda; Takeshi US 6330526 B1
Jung, Chul M. US 20050081172 A1
Bhamidipaty; Achyutram US 6874132 B1
Djaja; Gregory et al. US 6405160 B1

Databases Searched: EPO, JPO, IBM TDB, Derwent

Plurals: ON

Terms Searched:

L1 (transistor or transistor) same (current near3 (source or driver))
L2 (current near3 (source or driver)) near15 (width or dimension or size)
L3 resist\$5
L4 (model\$3 or character\$8 or represent\$6) same 1
L5 2 and 3 and 4

Results: 22 hits

L6 (transistor or transistor) same (replac\$6 or substitut\$4 or represent\$6 or model\$3 or character\$8) same current

L7 current same (width or size or dimension)

L8 current same (distribut\$4 or aggregat\$4 or combin\$7 or total) same 7

L9 3 and 6 and 8

Results: 62 hits

JP 09102608 A DERWENT AKINO, T et al.

Databases Searched: IEE/IEEE Xplore

Terms Searched: (transistor or transistor) and (current <near/3> (source or driver)) and (width or dimension or size) and resist* and (model* or character* or represent*)

Results: Your search matched 2 of 1356463 documents

Terms Searched: (transistor or transistor) and (replac* or substitut* or represent* or model* or character*) and current and (width or size or dimension) and (distribut* or aggregat* or combin* or total) and resist*

Results: Your search matched 32 of 1356463 documents